

Testing laboratory for climatic, mechanical and corrosive environmental stress

CERTIFICATE of QUALITY TEST Deutsche Akkreditierungsstelle D-PL-19102-01-00 Test report - No. 10996.04 / 14				
Client	Baumer Hübner GmbH Max-Dohrn-Str. 2 + 4 10589 Berlin			
Equipment under test	Sensor Head 1 sample manufacturing date	MHAP Nr. 5 December 2014		
Purpose	Test of the dynamic-mechanical robustness under defined environmental conditions			
Test program	Vibration, sinusoidal 30 g Shock, half-sine 300 g	according to IEC 60068-2-6 according to IEC 60068-2-27		
Test date	20 January to 21 January 2015			
Realization / results	see page 2 to 3			
Total number of pages	7 (incl. 2 appendices)			
Test result	During and after the tests of	the Sensor Head		

During and after the tests of the Sensor Head MHAP no external damages were determined. The further evaluation will be done by the client.

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Dipl.-Ing. M. Geburtig

test engineer



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1 <u>Purpose</u>

Test of the dynamic-mechanical robustness of the **Sensor Head MHAP** under defined environmental conditions.

2 Equipment under test (EUT)

Sensor Head	MHAP
Nr.	5
delivery date of the EUT	17 December 2014

3 Basics

3.1 Demands of the client

3.2 Used standards

IEC 60068-1:1988 + **Corr.** 1988 + **A1**:1992 **DIN EN 60068-1**:1995-03 "Environmental testing - Part 1: General and guidance"

IEC 60068-2-6:2007 **DIN EN 60068-2-6**; **VDE 0468-2-6**:2008-10 "Environmental testing - Part 2-6: Tests - Test Fc: Vibration (sinusoidal)"

IEC 60068-2-27:2008 DIN EN 60068-2-27; VDE 0468-2-27:2010-02 "Environmental testing - Part 2-27: Tests - Test Ea and guidance: Shock"

IEC 60068-2-47:2005 DIN EN 60068-2-47:2006-03 "Environmental testing - Part 2-47: Tests - Mounting of specimens for vibration, impact and similar dynamic tests"

4 Test program

4.1 <u>Vibration, sinusoidal - Test Fc</u>

according to IEC 60068-	2-6		
specimen		not operating	l
frequency range		55 - 2000 Hz	
acceleration	55 – 2000 Hz	294.3 m/s ²	(30 g)
sweep rate		1 octave / mi	n
number of axes		3	
test duration		1:30 h	(3 cycles per axis / 3 x 0:30 h)

4.2 Shock, half-sine - Test Ea

according to IEC 60068-2-27specimennot operatingacceleration2943 m/s²pulse durationapp. 1.5 msnumber of directions6test duration18 shocks(3 shocks in each direction)



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5 Realization

The environmental tests were carried out one by one according to the program of testing methods, according to the standards and to the demands of the client.

Visual inspection

Before and after each single test, the Sensor Head was examined visually for mechanical damages and any other changes.

Failure criteria

- mechanical or functional damages or any other changes

Fastening of the specimen during dynamic-mechanical tests

The specimen was mounted to an aluminum fixture by the client. This aluminum fixture with the specimen was directly installed in the respective axis on the vibration / shock table, see pictures in appendix 2

Measuring and test equipment	
vibration device	TV59335/AIT-440 (SN: 054-09, TIRA)
control channel 1 (vibration table)	acceleration sensor 353B18 (SN: 102393, PCB)
measuring channel 3 (specimen - red)	acceleration sensor 352C22 (SN: LW166820, PCB)
shock table	STT 800 (TIRA)
control channel 1 (shock table)	acceleration sensor 752-500 (SN: 12858, Endevco)
Low Impedance Coupler	5118B2 (SN: C160003, Kistler)
oscilloscope	SDS 200 (SN: 03-090032B, softDSP)

Results 6

6.1 Vibration, sinusoidal - Test

During and after the test of the Sensor Head MHAP with

- Vibration, sinusoidal

(10 – 2000 Hz, 294.3 m/s², 3 x 0:30 h, not operating)

no external damages nor other changes were determined at the specimen.

6.2 Shock, half-sine - Test Ea

During and after the test of the Sensor Head MHAP with

- Shock, half-sine

(2943 m/s², app. 1.5 ms, 6 x 3 shocks, not operating)

- Test Ea

- Test Fc

no external damages nor other changes were determined at the specimen.

During and after the tests of the Sensor Head MHAP no external damages were determined.

The further evaluation will be done by the client.

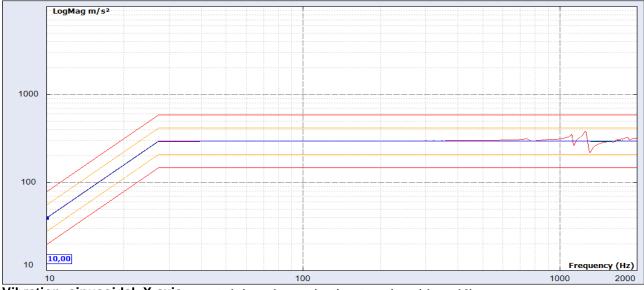
The results of the test only refer to the above mentioned equipment under test. The report or individual pages of this test report may only be copied following the written consent of the test laboratory. The test report-No. 10996.04 / 14 includes 3 pages and appendix 1 to 2.

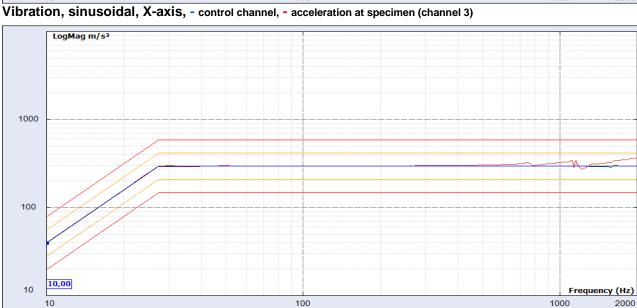
appendix 1 – vibration and shock protocols

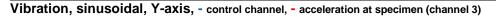
appendix 2 - pictures

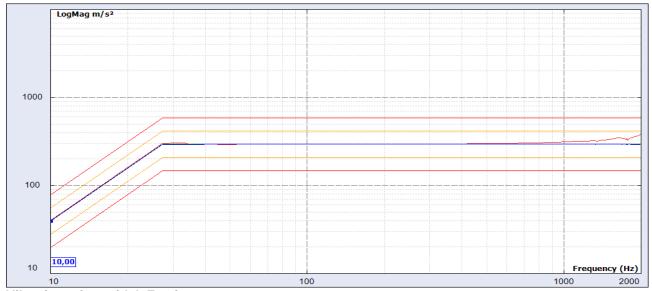


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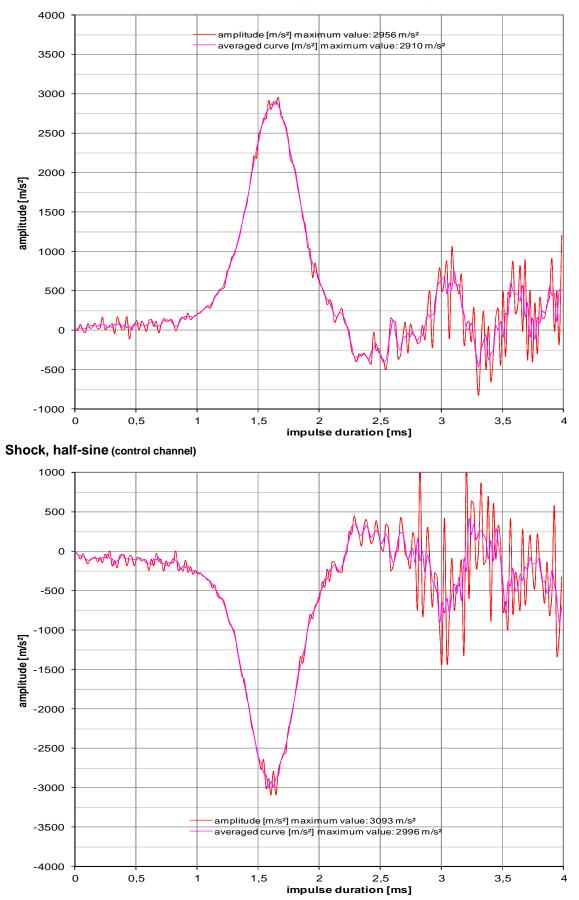






Vibration, sinusoidal, Z-axis, - control channel, - acceleration at specimen (channel 3)





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Shock, half-sine, inverted (control channel)



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Pictures



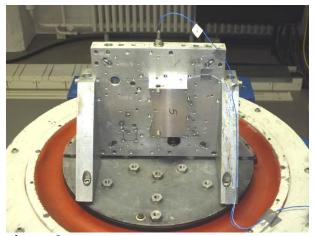
picture 1 Sensor Head MHAP on the vibration test device during vibration test in X-axis



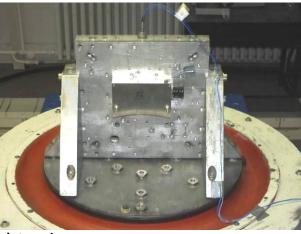
picture 3 Sensor Head MHAP specimens on the vibration test device during vibration test in Y-axis



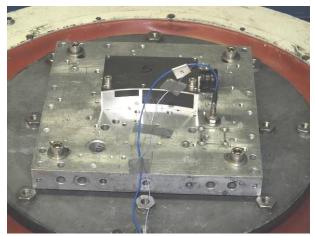
picture 5 Sensor Head MHAP specimen on the vibration test device during vibration test in Z-axis



picture 2 Sensor Head MHAP on the vibration table with acceleration sensors during vibration test in X-axis



picture 4 Sensor Head MHAP on the vibration table with acceleration sensors during vibration test in Y-axis



picture 6 Sensor Head MHAP on the vibration table with acceleration sensors during vibration test in Z-axis



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picture 7 Sensor Head MHAP on the shock table with acceleration sensor during shock test in X-axis, positive direction



picture 9 Sensor Head MHAP on the shock table with acceleration sensor during shock test in Y-axis, positive direction



picture 11 Sensor Head MHAP on the shock table with acceleration sensor during shock test in Z-axis, positive direction



picture 8 Sensor Head MHAP on the shock table with acceleration sensor during and shock test in X-axis, negative direction



picture 10 Sensor Head MHAP on the shock table with acceleration sensor during shock test in Y-axis, negative direction



picture 12 Sensor Head MHAP on the shock table with acceleration sensor during shock test in Z-axis, negative direction